

Functional Safety Information

**TPSI2240-Q1, TPSI2240C-Q1, and TPSI2240T-Q1**

**Functional Safety FIT Rate, FMD and Pin FMA**

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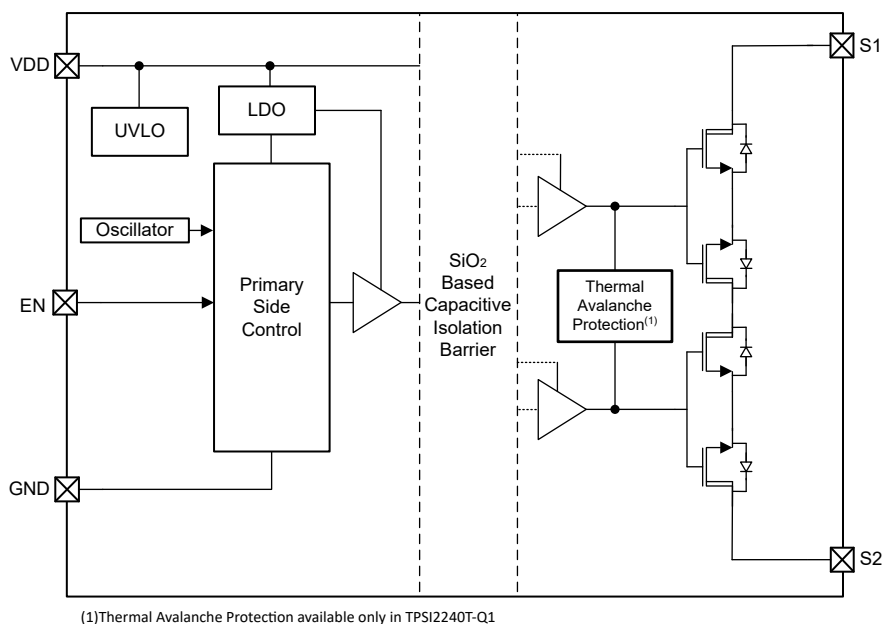
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## 1 Overview

This document contains information for TPSI2240-Q1, TPSI2240C-Q1, and TPSI2240T-Q1 (11 DWQ package) to aid in a functional safety system design. Information provided are:

- Functional safety failure in time (FIT) rates of the semiconductor component estimated by the application of industry reliability standards
- Component failure modes and distribution (FMD) based on the primary function of the device
- Pin failure mode analysis (pin FMA)

Figure 1-1 shows the functional block diagram of TPSI2240-Q1, TPSI2240C-Q1, and TPSI2240T-Q1 for reference.



**Figure 1-1. TPSI2240-Q1, TPSI2240C-Q1, and TPSI2240T-Q1 Functional Block Diagram**

TPSI2240-Q1, TPSI2240C-Q1, and TPSI2240T-Q1 were developed using a quality-managed development process, but were not developed in accordance with IEC 61508 or ISO 26262 standards.

## 2 Functional Safety Failure In Time (FIT) Rates

This section provides functional safety failure in time (FIT) rates for the TPSI2240-Q1, TPSI2240C-Q1, and TPSI2240T-Q1 based on two different industry-wide used reliability standards:

- [Table 2-1](#) provides FIT rates based on IEC TR 62380 / ISO 26262 part 11
- [Table 2-2](#) provides FIT rates based on the Siemens Norm SN 29500-2

**Table 2-1. Component Failure Rates per IEC TR 62380 / ISO 26262 Part 11**

FIT IEC TR 62380 / ISO 26262	FIT (Failures Per 10 <sup>9</sup> Hours)
Total component FIT rate	22
Die FIT rate	4
Package FIT rate	18

The failure rate and mission profile information in [Table 2-1](#) comes from the reliability data handbook IEC TR 62380 / ISO 26262 part 11:

- Mission profile: Motor control from table 11 or figure 16
- Power dissipation: 200mW
- Climate type: World-wide table 8 or figure 13
- Package factor ( $\lambda_3$ ): Table 17b or figure 15
- Substrate material: FR4
- EOS FIT rate assumed: 0 FIT

**Table 2-2. Component Failure Rates per Siemens Norm SN 29500-2**

Table	Category	Reference FIT Rate	Reference Virtual T <sub>J</sub>
5	CMOS, BICMOS Digital, analog, or mixed	30 FIT	75°C

The reference FIT rate and reference virtual T<sub>J</sub> (junction temperature) in [Table 2-2](#) come from the Siemens Norm SN 29500-2 tables 1 through 5. Failure rates under operating conditions are calculated from the reference failure rate and virtual junction temperature using conversion information in SN 29500-2 section 4.

### 3 Failure Mode Distribution (FMD)

The failure mode distribution estimation for TPSI2240-Q1, TPSI2240C-Q1, and TPSI2240T-Q1 in [Table 3-1](#) comes from the combination of common failure modes listed in standards such as IEC 61508 and ISO 26262, the ratio of sub-circuit function size and complexity, and from best engineering judgment.

The failure modes listed in this section reflect random failure events and do not include failures resulting from misuse or overstress.

**Table 3-1. Die Failure Modes and Distribution**

Die Failure Modes	Failure Mode Distribution (%)
Switch stuck OFF	5.5
Switch OFF – current higher than specification	42
Switch partially ON when enabled	47
Primary side ON – current higher than specification	5.5

## 4 Pin Failure Mode Analysis (Pin FMA)

This section provides a failure mode analysis (FMA) for the pins of the TPSI2240-Q1, TPSI2240C-Q1, and TPSI2240T-Q1. The failure modes covered in this document include the typical pin-by-pin failure scenarios:

- Pin short-circuited to ground (see [Table 4-2](#))
- Pin short-circuited to VDD (See [Table 4-3](#))
- Pin open-circuited (see [Table 4-4](#))
- Pin short-circuited to adjacent pin (see [Table 4-5](#))

[Table 4-2](#) through [Table 4-5](#) also indicate how these pin conditions can affect the device as per the failure effects classification in [Table 4-1](#).

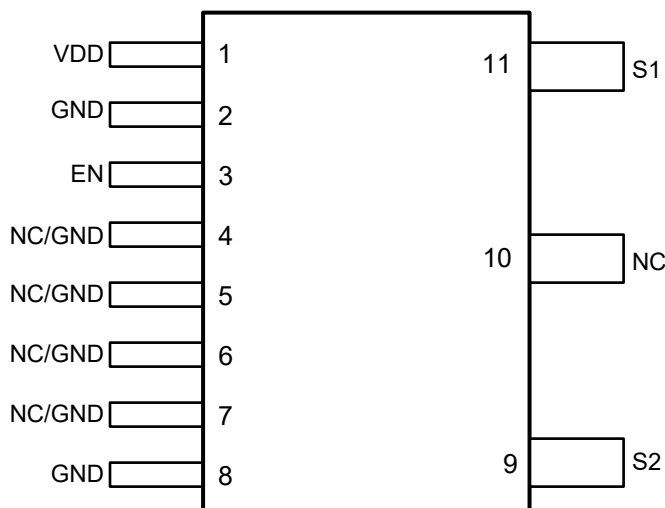
### Note

When the pin short to ground case is discussed, only primary-side ground shorts are considered.

**Table 4-1. TI Classification of Failure Effects**

Class	Failure Effects
A	Potential device damage that affects functionality.
B	No device damage, but loss of functionality.
C	No device damage, but performance degradation.
D	No device damage, no impact to functionality or performance.

[Figure 4-1](#) shows the TPSI2240-Q1, TPSI2240C-Q1, and TPSI2240T-Q1 pin diagram. For a detailed description of the device pins, see the *Pin Configuration and Functions* section in the TPSI2240-Q1, TPSI2240C-Q1, and TPSI2240T-Q1 datasheets.



**Figure 4-1. TPSI2240-Q1, TPSI2240C-Q1, and TPSI2240T-Q1 Pin Diagram**

**Table 4-2. Pin FMA for Device Pins Short-Circuited to Ground**

Pin Name	Pin No.	Description of Potential Failure Effects	Failure Effect Class
VDD	1	The device is in the OFF state (UVLO). The secondary-side switch is in the OFF state.	B
GND	2	There is no effect on the device.	D
EN	3	The device is in the OFF state. The secondary-side switch is in the OFF state.	B
NC/GND	4	There is no effect on the device.	D
NC/GND	5	There is no effect on the device.	D
NC/GND	6	There is no effect on the device.	D
NC/GND	7	There is no effect on the device.	D
GND	8	There is no effect on the device.	D
S2	9	N/A	N/A
NC	10	N/A	N/A
S1	11	N/A	N/A

**Table 4-3. Pin FMA for Device Pins Short-Circuited to VDD**

Pin Name	Pin No.	Description of Potential Failure Effects	Failure Effect Class
VDD	1	There is no effect on the device.	D
GND	2	The device is in the OFF state (UVLO), the secondary-side switch is in the OFF state.	B
EN	3	The device is in the ON state. The secondary side switch is in the ON state.	B
NC/GND	4	If pin 3 is high, there is no effect on the device.	D
		If pin 3 is low, the standoff voltage of the secondary side switch is halved.	C
NC/GND	5	If pin 3 is high, there is no effect on the device.	D
		If pin 3 is low, the standoff voltage of the secondary side switch is halved.	C
NC/GND	6	There is no effect on the device.	D
NC/GND	7	There is no effect on the device.	D
GND	8	The device is in the OFF state (UVLO), the secondary-side switch is in the OFF state.	B
S2	9	N/A	N/A
NC	10	N/A	N/A
S1	11	N/A	N/A

**Table 4-4. Pin FMA for Device Pins Open-Circuited**

Pin Name	Pin No.	Description of Potential Failure Effects	Failure Effect Class
VDD	1	The device is in the OFF state (UVLO). The secondary-side switch is in the OFF state.	B
GND	2	If pin 8 is not connected, the device is in the OFF state (UVLO), the secondary-side switch is in the OFF state.	B
EN	3	The device is in the OFF state. The secondary-side switch is in the OFF state.	B
NC/GND	4	There is no effect on the device.	D
NC/GND	5	There is no effect on the device.	D
NC/GND	6	There is no effect on the device.	D
NC/GND	7	There is no effect on the device.	D
GND	8	If pin 2 is not connected, the device is in the OFF state (UVLO), the secondary-side switch is in the OFF state.	B
S2	9	There is no effect on the device.	D
NC	10	There is no effect on the device.	D
S1	11	There is no effect on the device.	D

**Table 4-5. Pin FMA for Device Pins Short-Circuited to Adjacent Pin**

Pin Name	Pin No.	Shorted to Pin No.	Description of Potential Failure Effects	Failure Effect Class
VDD	1	2	The device is in the OFF state (UVLO). The secondary-side switch is in the OFF state.	B
GND	2	3	The device is in the OFF state. The secondary-side switch is in the OFF state.	B
EN	3	4	No effect if pin 4 is NC, if pin 4 is GND, the device is in the OFF state, and the secondary-side switch is in the OFF state.	D B
NC/GND	4	5	There is no effect on the device.	D
NC/GND	5	6	There is no effect on the device.	D
NC/GND	6	7	There is no effect on the device.	D
NC/GND	7	8	There is no effect on the device.	D
GND	8	9	N/A	N/A
S2	9	10	There is no effect on the device.	D
NC	10	11	There is no effect on the device.	D
S1	11	1	N/A	N/A

## 5 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

### Changes from December 11, 2025 to January 22, 2026 (from Revision \* (December 2015) to Revision A (January 2026))

Page

- Added the TPSI2240C-Q1 and TPSI2240T-Q1 devices..... 2

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